Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/759,414	LI, ZHE	
Examiner	Art Unit	-
Thomas H. Stevens	2123	

SEARCHED				
Class	Subclass	Date	Examiner	
			-	
714	٤(	1/4/06	73	
715	514	(c	1)	
703	14	,	ţ i	
			****	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	-		
	-		
US PG H4106 See se	PUB ilizloc arch		TJ
repor	<b>r</b> 4		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE .	EXMR
Google: Inventor Schdar	113/06	27
Google Scholar: digital functional circuits	. \	
INSPEC: Inventor		
INSPEC: "debugger  "Probe"		
"circuit"		1